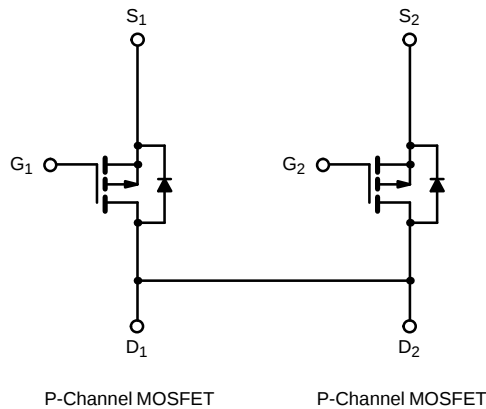
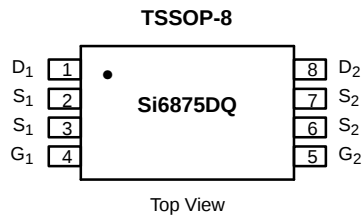




Dual P-Channel 20-V (D-S) MOSFET, Common Drain

PRODUCT SUMMARY

V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
-20	0.027 @ $V_{GS} = -4.5$ V	-6.4
	0.036 @ $V_{GS} = -2.5$ V	-5.5
	0.052 @ $V_{GS} = -1.8$ V	-4.6

TrenchFET[®]
Power MOSFETs
1.8-V RatedABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter		Symbol	10 secs	Steady State	Unit
Drain-Source Voltage		V _{DS}	−20		V
Gate-Source Voltage		V _{GS}	± 8		
Continuous Drain Current (T _J = 150 °C) ^a	T _A = 25 °C	I _D	−6.4	−5.2	A
	T _A = 70 °C		−5.1	−4.1	
Pulsed Drain Current (10 μs Pulse Width)		I _{DM}	−30		
Continuous Source Current (Diode Conduction) ^a		I _S	−1.6	−1.08	W
Maximum Power Dissipation ^a	T _A = 25 °C	P _D	1.78	1.19	
	T _A = 70 °C		1.14	0.76	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	−55 to 150		°C

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^a	$t \leq 10$ sec	R_{thJA}	55	70	$^\circ\text{C/W}$
	Steady State		85	105	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	35	45	

Notes

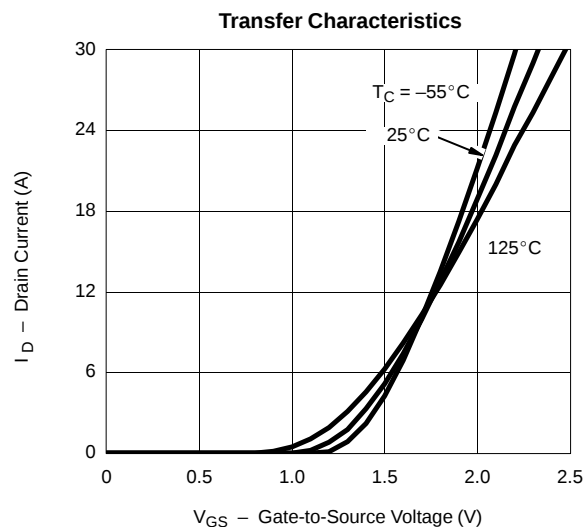
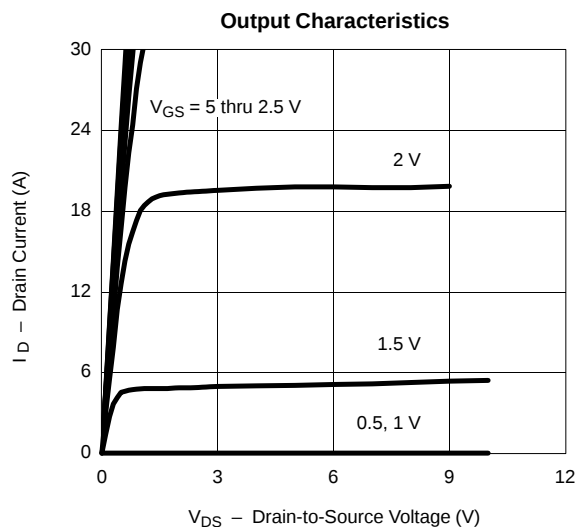
a. Surface Mounted on 1" x 1" FR4 Board.

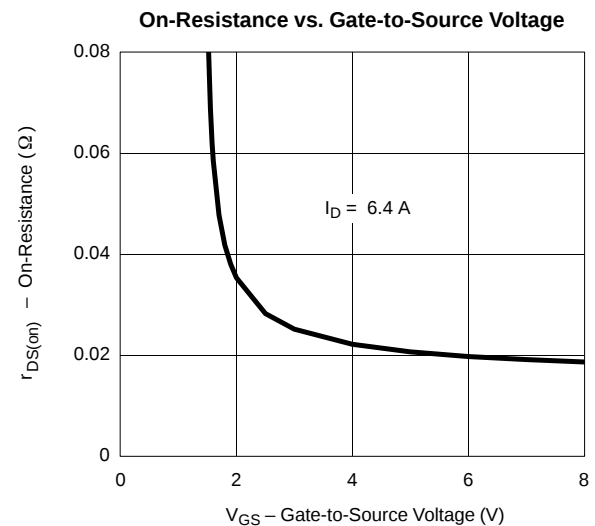
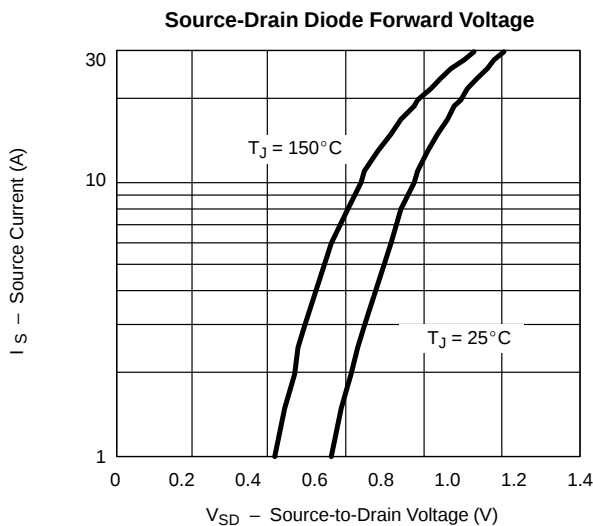
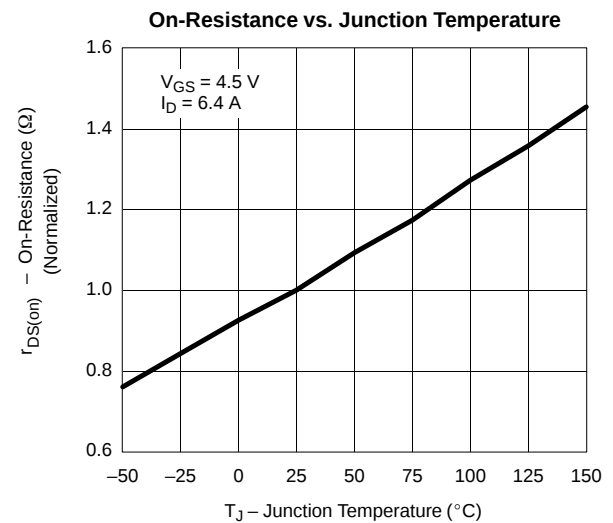
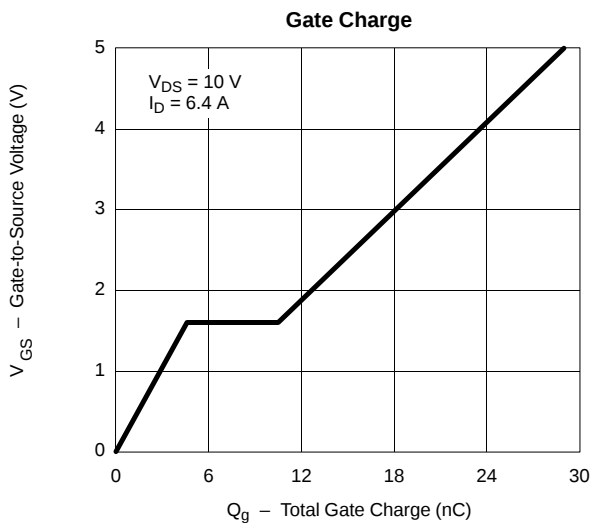
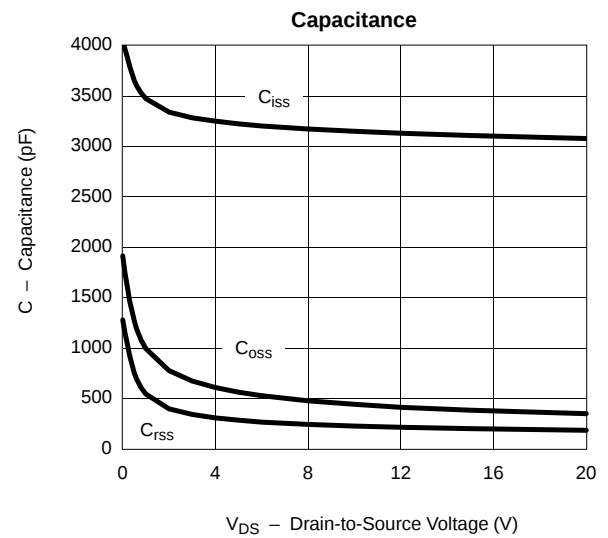
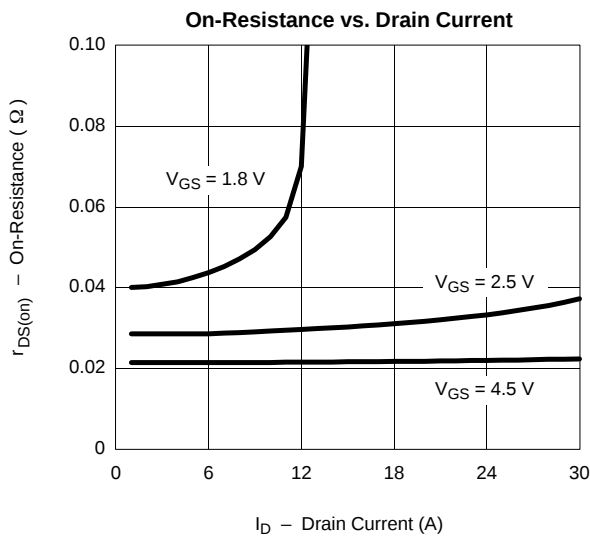
SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = -250\ \mu\text{A}$	-0.45			V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\ \text{V}$, $V_{GS} = \pm 8\ \text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -16\ \text{V}$, $V_{GS} = 0\ \text{V}$			-1	μA
		$V_{DS} = -16\ \text{V}$, $V_{GS} = 0\ \text{V}$, $T_J = 70^\circ\text{C}$			-25	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} = -5\ \text{V}$, $V_{GS} = -4.5\ \text{V}$	-20			A
Drain-Source On-State Resistance ^a	$r_{DS(on)}$	$V_{GS} = -4.5\ \text{V}$, $I_D = -6.4\ \text{A}$		0.022	0.027	Ω
		$V_{GS} = -2.5\ \text{V}$, $I_D = -5.5\ \text{A}$		0.029	0.036	
		$V_{GS} = -1.8\ \text{V}$, $I_D = -4.6\ \text{A}$		0.042	0.052	Ω
Forward Transconductance ^a	g_{fs}	$V_{DS} = -5\ \text{V}$, $I_D = -6.4\ \text{A}$		19		S
Diode Forward Voltage ^a	V_{SD}	$I_S = -1.6\ \text{A}$, $V_{GS} = 0\ \text{V}$		-0.70	-1.1	V
Dynamic^b						
Total Gate Charge	Q_g	$V_{DS} = -10\ \text{V}$, $V_{GS} = -4.5\ \text{V}$, $I_D = -6.4\ \text{A}$		26	36	nC
Gate-Source Charge	Q_{gs}			4.6		
Gate-Drain Charge	Q_{gd}			5.9		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -10\ \text{V}$, $R_L = 10\ \Omega$ $I_D \approx -1\ \text{A}$, $V_{GEN} = -4.5\ \text{V}$, $R_G = 6\ \Omega$		26	40	ns
Rise Time	t_r			27	40	
Turn-Off Delay Time	$t_{d(off)}$			170	250	
Fall Time	t_f			75	110	
Source-Drain Reverse Recovery Time	t_{rr}	$I_F = -1.6\ \text{A}$, $di/dt = 100\ \text{A}/\mu\text{s}$		30	50	

Notes

- a. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.
b. Guaranteed by design, not subject to production testing.

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

**TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)**

TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)
